

Search Notes**Application/Control No.**

10/586,108

Examiner

CHRIS H. CHU

**Applicant(s)/Patent under
Reexamination**

GAUDREAU, JEAN-ETIENNE

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
applicant's cited references	12/11/2008	/CC/
text search	12/11/2008	/CC/
class 349, further limiting with text	12/11/2008	/CC/